## Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/772,311	LEE ET AL.	
Examiner	Art Unit	
EDMUND H. LEE	1791	

SEARCHED						
Class	Subclass	Date	Examiner			

INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		
	272.15,272.1 8.9.328.12	6/29/2009	EHL		

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
updated	6/29/2009	EHL		